

# MOS FIELD EFFECT TRANSISTOR

# $\mu$ PA1706TP

## SWITCHING

### N-CHANNEL POWER MOS FET

#### DESCRIPTION

The  $\mu$ PA1706TP which has a heat spreader is N-Channel MOS Field Effect Transistor designed for DC/DC converter and power management application of notebook computer.

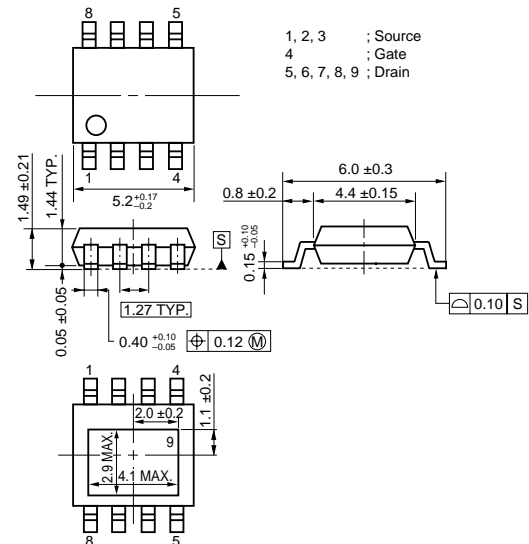
#### FEATURES

- Low on-state resistance  
 $R_{DS(on)1} = 7.8 \text{ m}\Omega \text{ MAX. (} V_{GS} = 10 \text{ V, } I_D = 7.0 \text{ A)}$   
 $R_{DS(on)2} = 10.0 \text{ m}\Omega \text{ MAX. (} V_{GS} = 4.5 \text{ V, } I_D = 7.0 \text{ A)}$
- Low  $C_{iss}$ :  $C_{iss} = 3000 \text{ pF TYP. (} V_{DS} = 10 \text{ V, } V_{GS} = 0 \text{ V)}$
- Small and surface mount package (Power HSOP8)

#### ORDERING INFORMATION

PART NUMBER	PACKAGE
$\mu$ PA1706TP	Power HSOP8

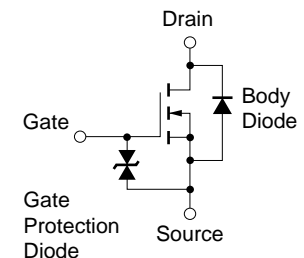
#### PACKAGE DRAWING (Unit: mm)



#### ABSOLUTE MAXIMUM RATINGS (T<sub>A</sub> = 25°C, All terminals are connected.)

Drain to Source Voltage (V <sub>GS</sub> = 0 V)	V <sub>DSS</sub>	30	V
Gate to Source Voltage (V <sub>DS</sub> = 0 V)	V <sub>GSS</sub>	±20	V
Drain Current (DC) (T <sub>c</sub> = 25°C)	I <sub>D(DC)1</sub>	±28	A
Drain Current (DC) <sup>Note1</sup>	I <sub>D(DC)2</sub>	±17	A
Drain Current (pulse) <sup>Note2</sup>	I <sub>D(pulse)</sub>	±100	A
Total Power Dissipation (T <sub>c</sub> = 25°C)	P <sub>T1</sub>	39	W
Total Power Dissipation <sup>Note1</sup>	P <sub>T2</sub>	3	W
Channel Temperature	T <sub>ch</sub>	150	°C
Storage Temperature	T <sub>stg</sub>	-55 to + 150	°C
Single Avalanche Current <sup>Note3</sup>	I <sub>AS</sub>	19	A
Single Avalanche Energy <sup>Note3</sup>	E <sub>AS</sub>	36.1	mJ

#### EQUIVALENT CIRCUIT



- Notes**
1. Mounted on a glass epoxy board (1 inch x 1 inch x 0.8 mm), PW = 10 sec
  2. PW ≤ 10 μs, Duty cycle ≤ 1%
  3. Starting T<sub>ch</sub> = 25°C, V<sub>DD</sub> = 15 V, R<sub>G</sub> = 25 Ω, L = 100 μH, V<sub>GS</sub> = 20 → 0 V

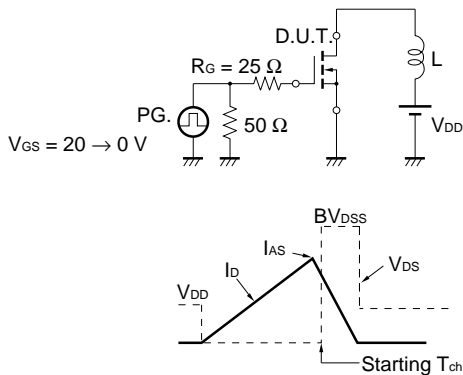
**Remark** The diode connected between the gate and source of the transistor serves as a protector against ESD. When this device actually used, an additional protection circuit is externally required if a voltage exceeding the rated voltage may be applied to this device.

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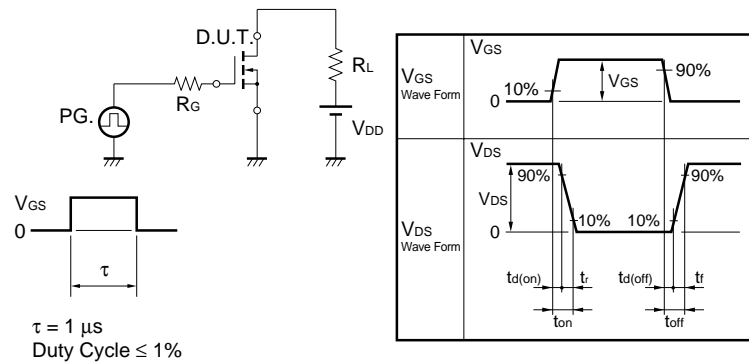
**ELECTRICAL CHARACTERISTICS (T<sub>A</sub> = 25°C, All terminals are connected.)**

CHARACTERISTICS	SYMBOL	TEST CONDITIONS	MIN.	TYP.	MAX.	UNIT
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	V <sub>DS</sub> = 30 V, V <sub>GS</sub> = 0 V			10	μA
Gate Leakage Current	I <sub>GSS</sub>	V <sub>GS</sub> = ±20 V, V <sub>DS</sub> = 0 V			±10	μA
Gate Cut-off Voltage	V <sub>GS(off)</sub>	V <sub>DS</sub> = 10 V, I <sub>D</sub> = 1 mA	1.5	2.0	2.5	V
Forward Transfer Admittance	y <sub>fs</sub>	V <sub>DS</sub> = 10 V, I <sub>D</sub> = 7.0 A	10	22		S
Drain to Source On-state Resistance	R <sub>DS(on)1</sub>	V <sub>GS</sub> = 10 V, I <sub>D</sub> = 7.0 A		5.8	7.8	mΩ
	R <sub>DS(on)2</sub>	V <sub>GS</sub> = 4.5 V, I <sub>D</sub> = 7.0 A		7.0	10.0	mΩ
	R <sub>DS(on)3</sub>	V <sub>GS</sub> = 4.0 V, I <sub>D</sub> = 7.0 A		8.0	12.0	mΩ
Input Capacitance	C <sub>iss</sub>	V <sub>DS</sub> = 10 V		3000		pF
Output Capacitance	C <sub>oss</sub>	V <sub>GS</sub> = 0 V		950		pF
Reverse Transfer Capacitance	C <sub>rss</sub>	f = 1 MHz		380		pF
Turn-on Delay Time	t <sub>d(on)</sub>	V <sub>DD</sub> = 15 V, I <sub>D</sub> = 13 A		20		ns
Rise Time	t <sub>r</sub>	V <sub>GS</sub> = 10 V		20		ns
Turn-off Delay Time	t <sub>d(off)</sub>	R <sub>G</sub> = 10 Ω		80		ns
Fall Time	t <sub>f</sub>			30		ns
Total Gate Charge	Q <sub>G</sub>	V <sub>DD</sub> = 24 V		56		nC
Gate to Source Charge	Q <sub>GS</sub>	V <sub>GS</sub> = 10 V		9		nC
Gate to Drain Charge	Q <sub>GD</sub>	I <sub>D</sub> = 13 A		14		nC
Body Diode Forward Voltage	V <sub>F(S-D)</sub>	I <sub>F</sub> = 13 A, V <sub>GS</sub> = 0 V		0.8		V
Reverse Recovery Time	t <sub>rr</sub>	I <sub>F</sub> = 13 A, V <sub>GS</sub> = 0 V		43		ns
Reverse Recovery Charge	Q <sub>rr</sub>	di/dt = 100 A/μs		50		nC

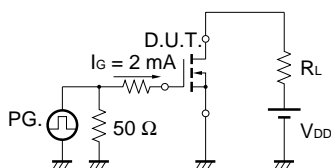
**TEST CIRCUIT 1 AVALANCHE CAPABILITY**



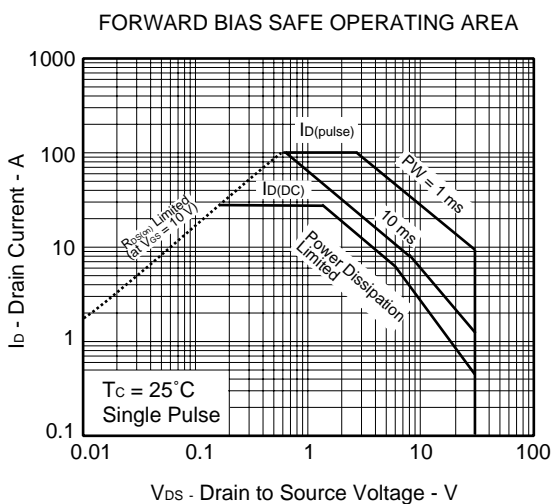
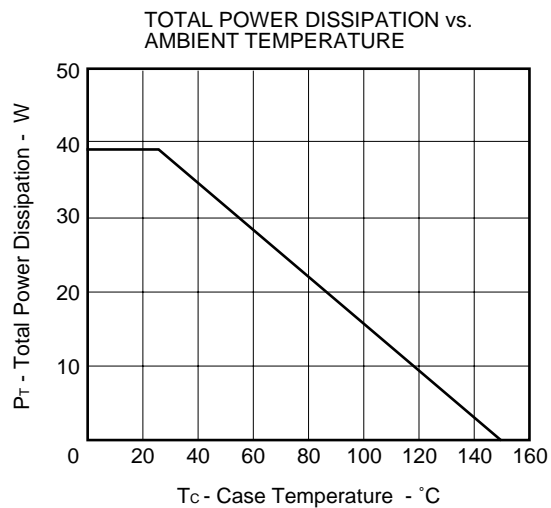
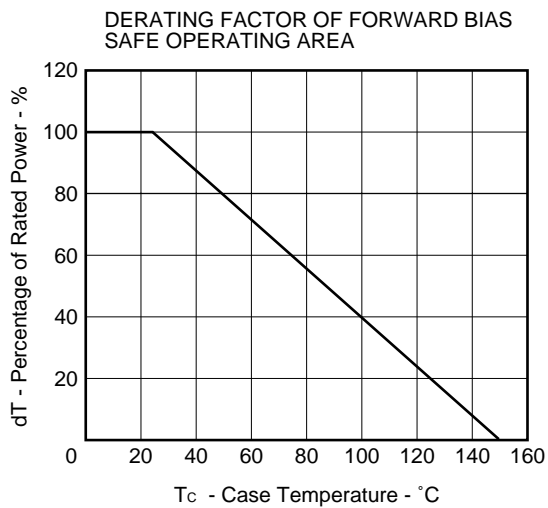
**TEST CIRCUIT 2 SWITCHING TIME**



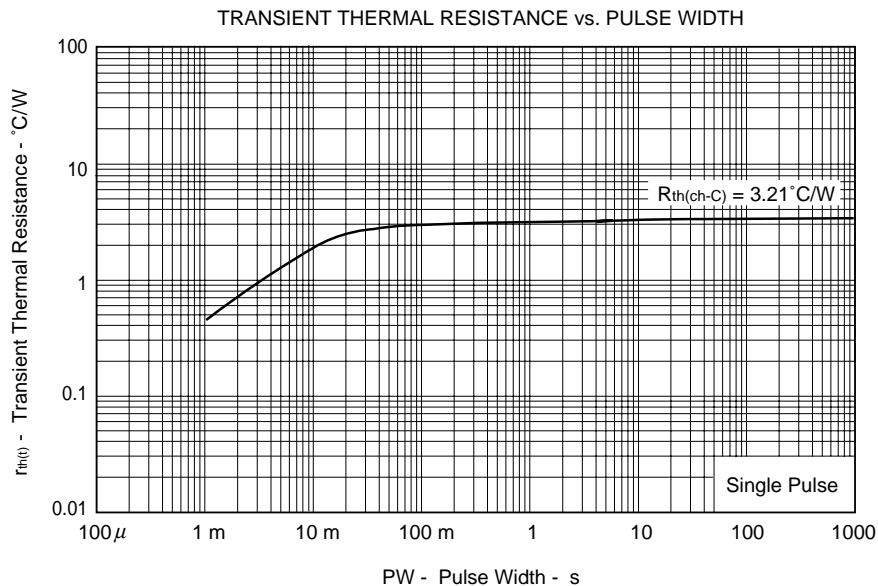
**TEST CIRCUIT 3 GATE CHARGE**

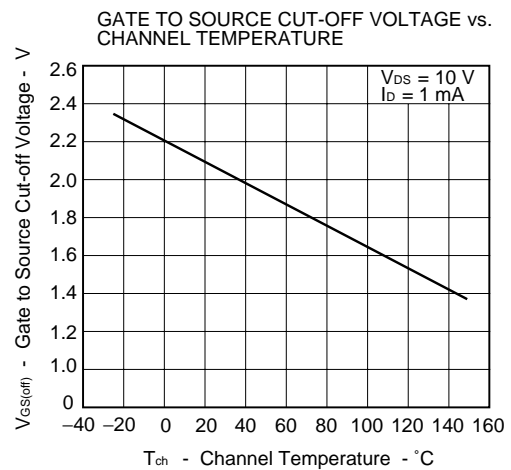
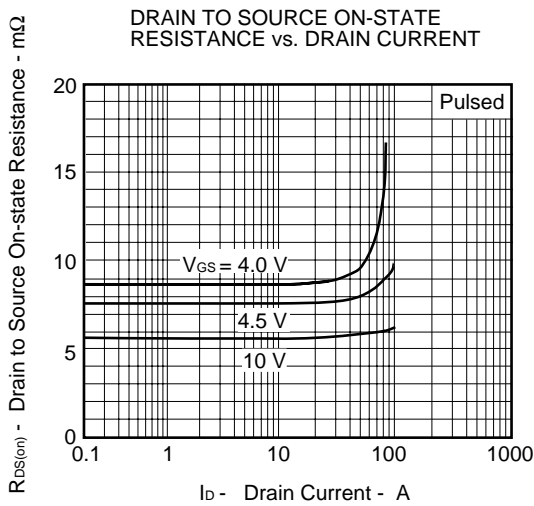
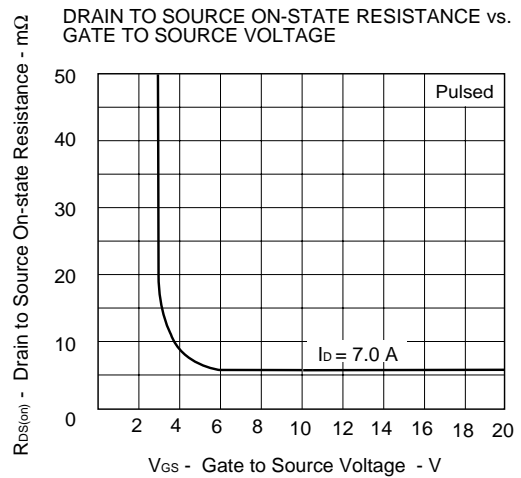
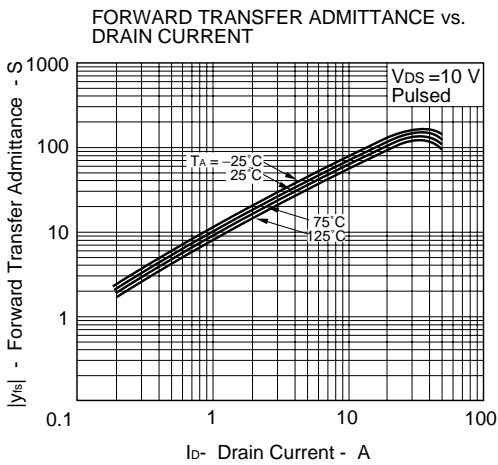
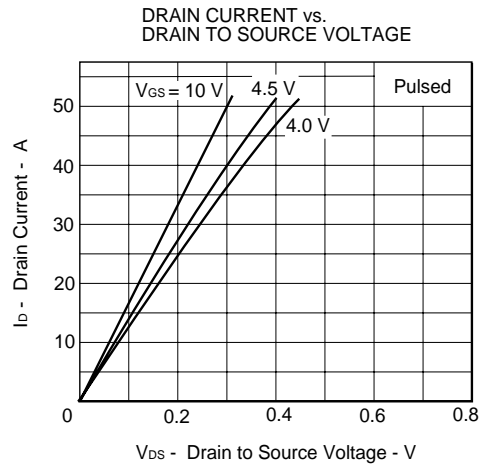
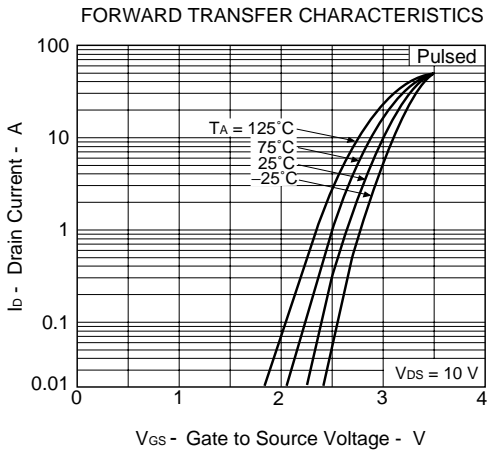


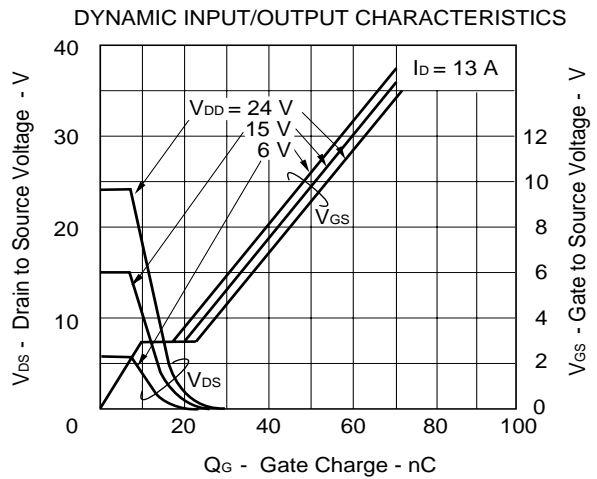
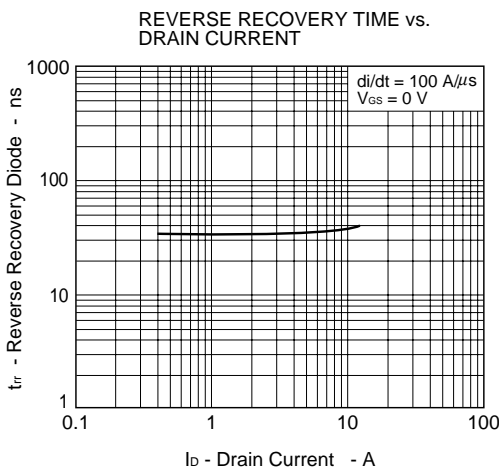
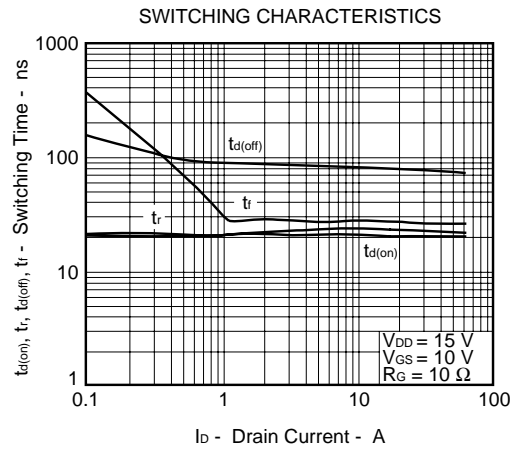
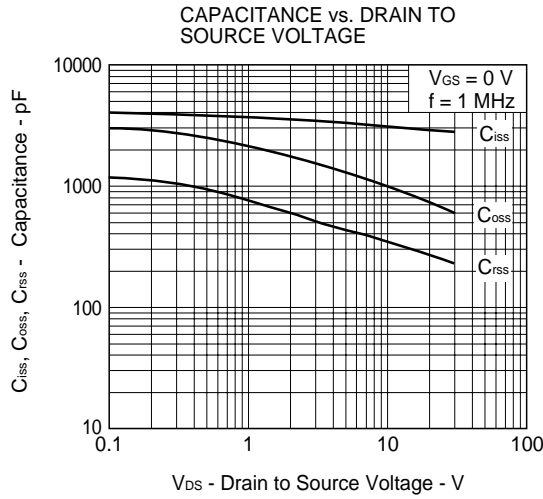
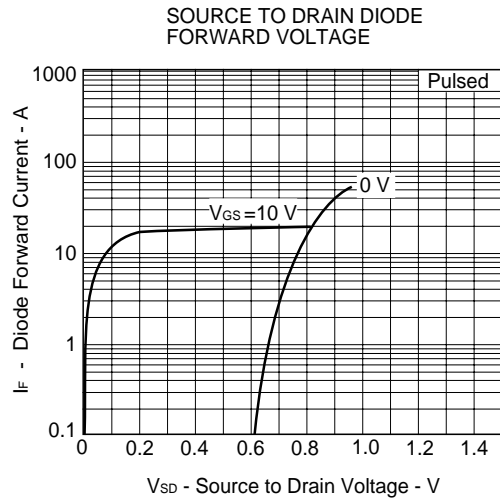
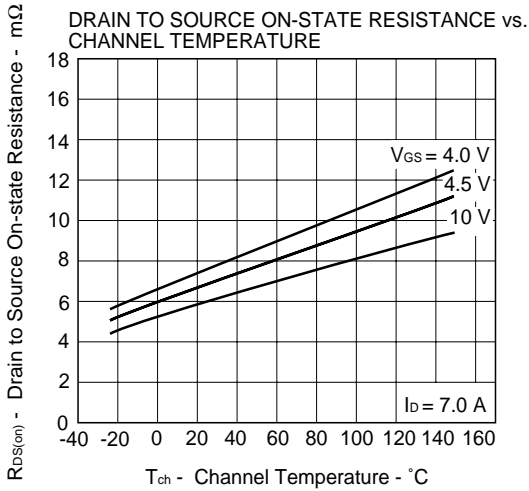
TYPICAL CHARACTERISTICS (T<sub>A</sub> = 25°C)



V<sub>DS</sub> - Drain to Source Voltage - V







[MEMO]

[MEMO]

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